

[54] **ELECTRONIC TESTING DEVICE FOR A MICROPROCESSOR**

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[73] **Assignee: Ugly Products, Gardena, Calif.**

[\*\*] **Term: 14 Years**

[21] **Appl. No.: 339,667**

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[52] **U.S. Cl. .... D10/75; D13/24**

[58] **Field of Search ..... D10/46, 75, 78, 81, D10/102, 103; D13/24; 324/73 R, 73 PC, 158 F; 339/17 R, 17 CF, 17 LC, 18 R, 18 B, 147 R**

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*Micro Logic Corp. Flyer—Microprocessor Viewer on front-top.*

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[57] **CLAIM**

The ornamental design for an electronic testing device for a microprocessor, as shown and described.

**DESCRIPTION**

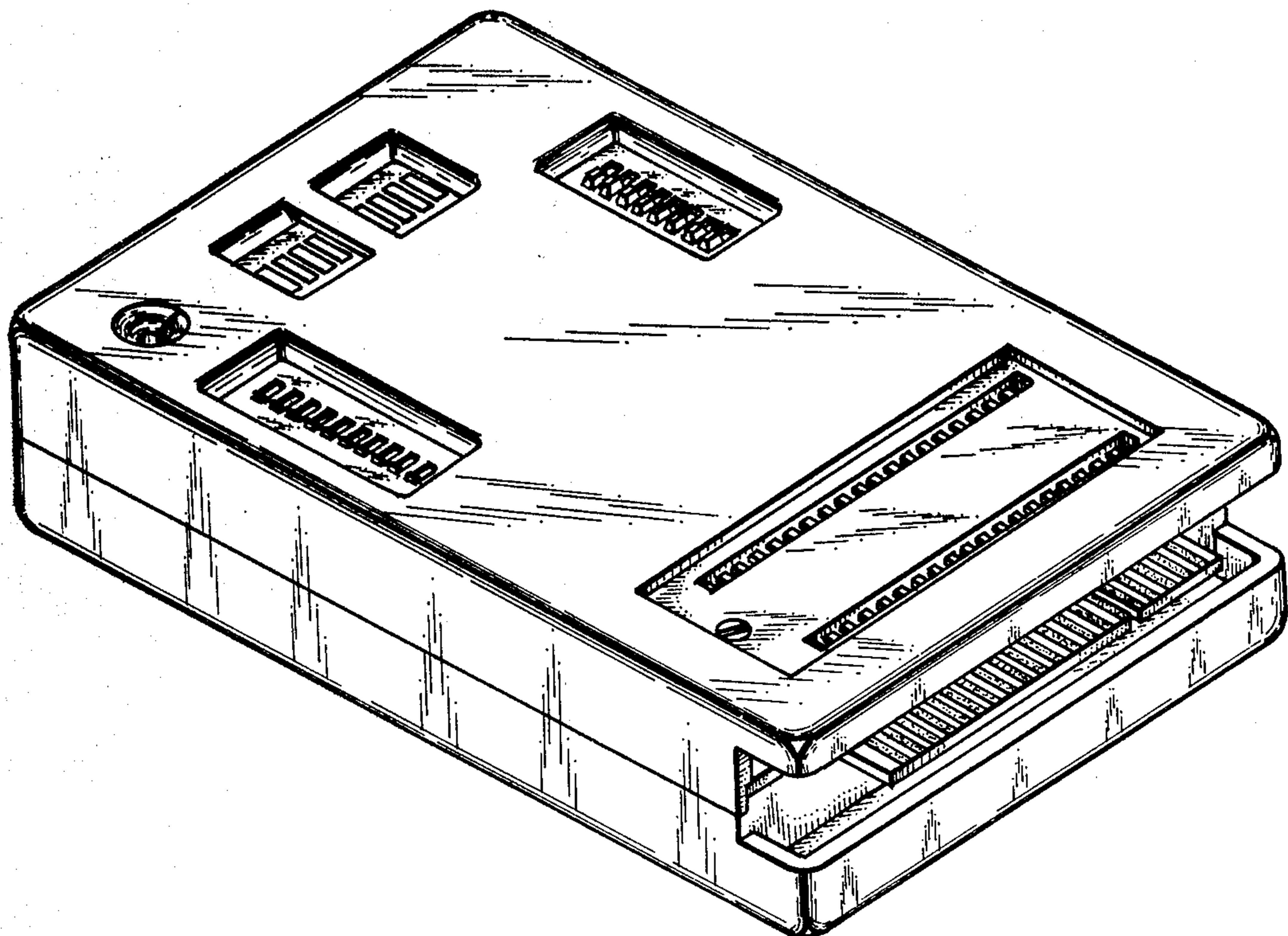
FIG. 1 is a top and right front perspective view of an electronic testing device for a microprocessor showing my new design;

FIG. 2 is a right side elevational view thereof;

FIG. 3 is a rear elevational view thereof;

FIG. 4 is a left side elevational view thereof;

FIG. 5 is a bottom plan view thereof.



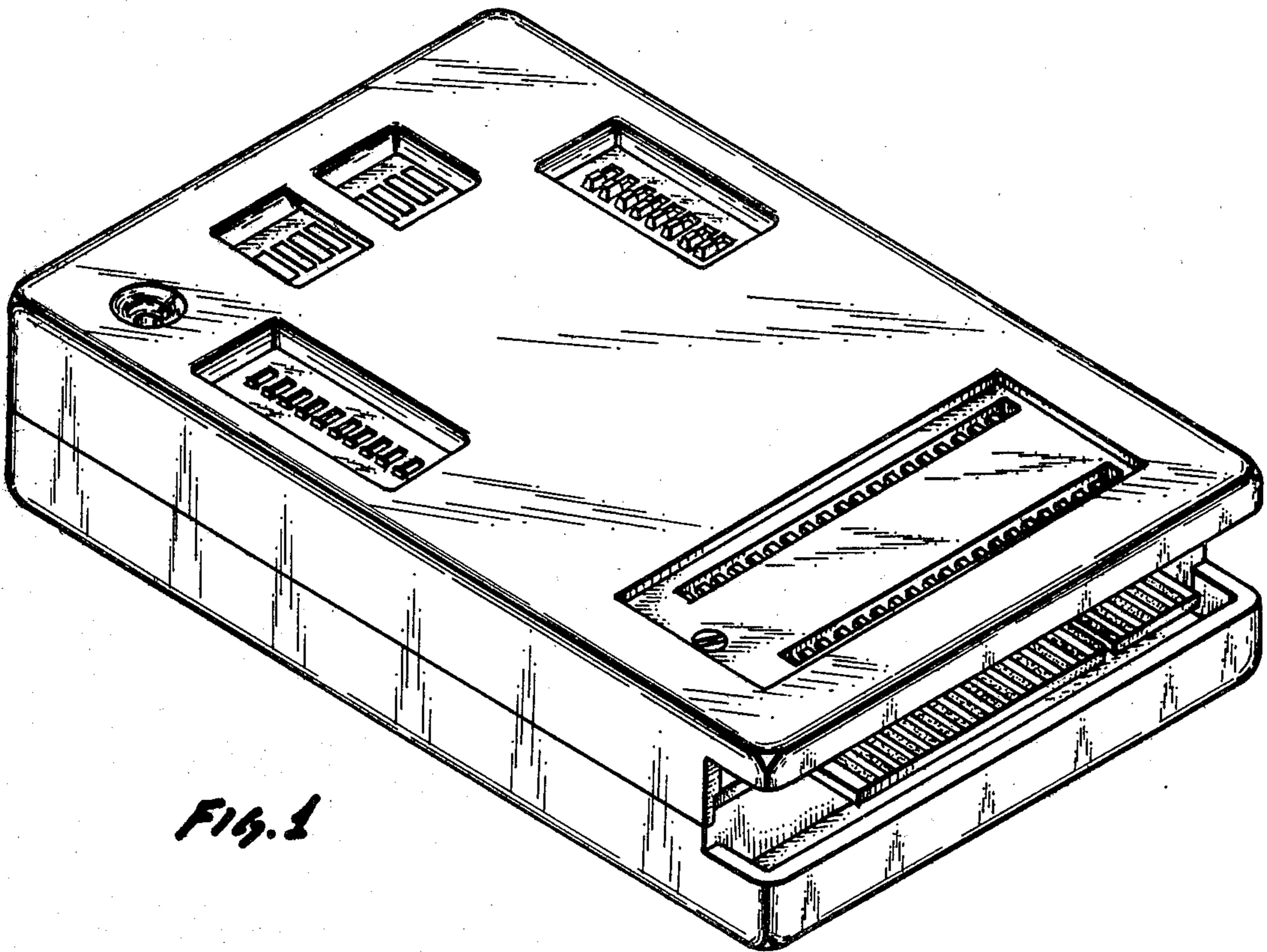


Fig. 1

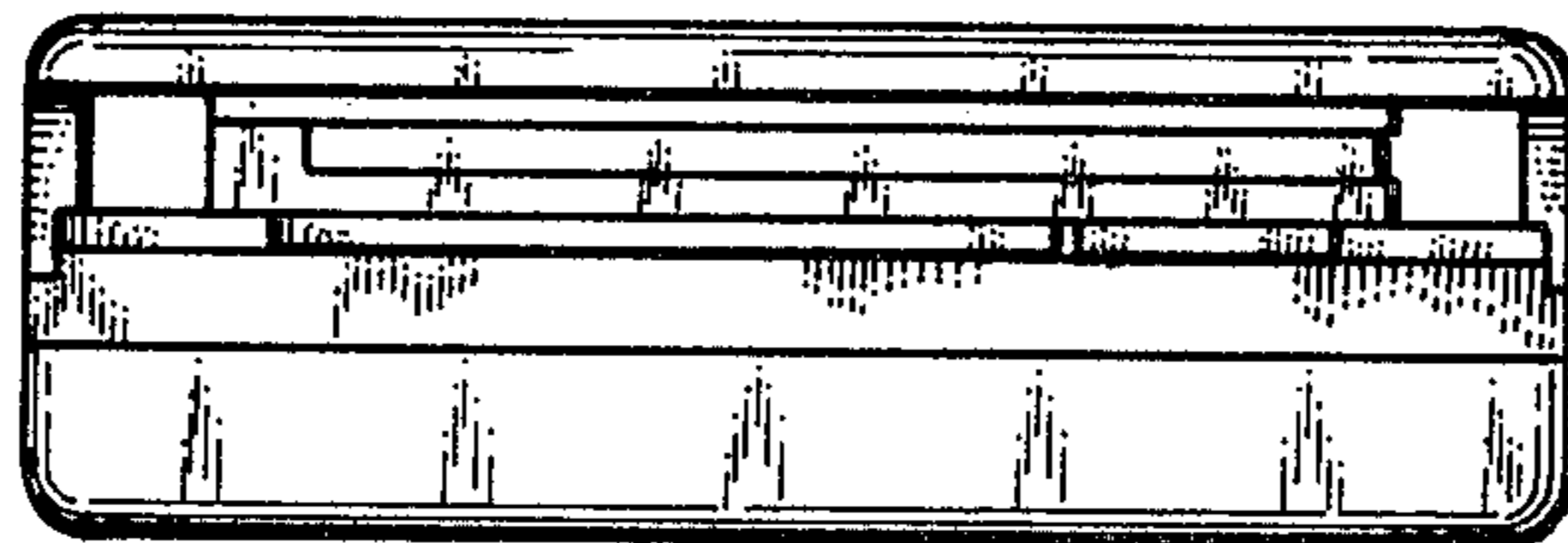
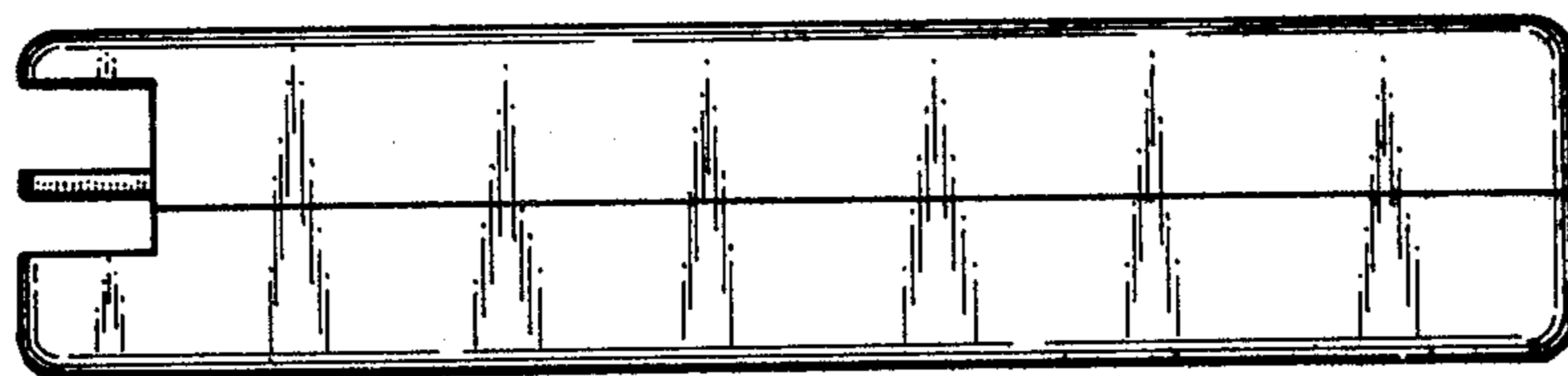
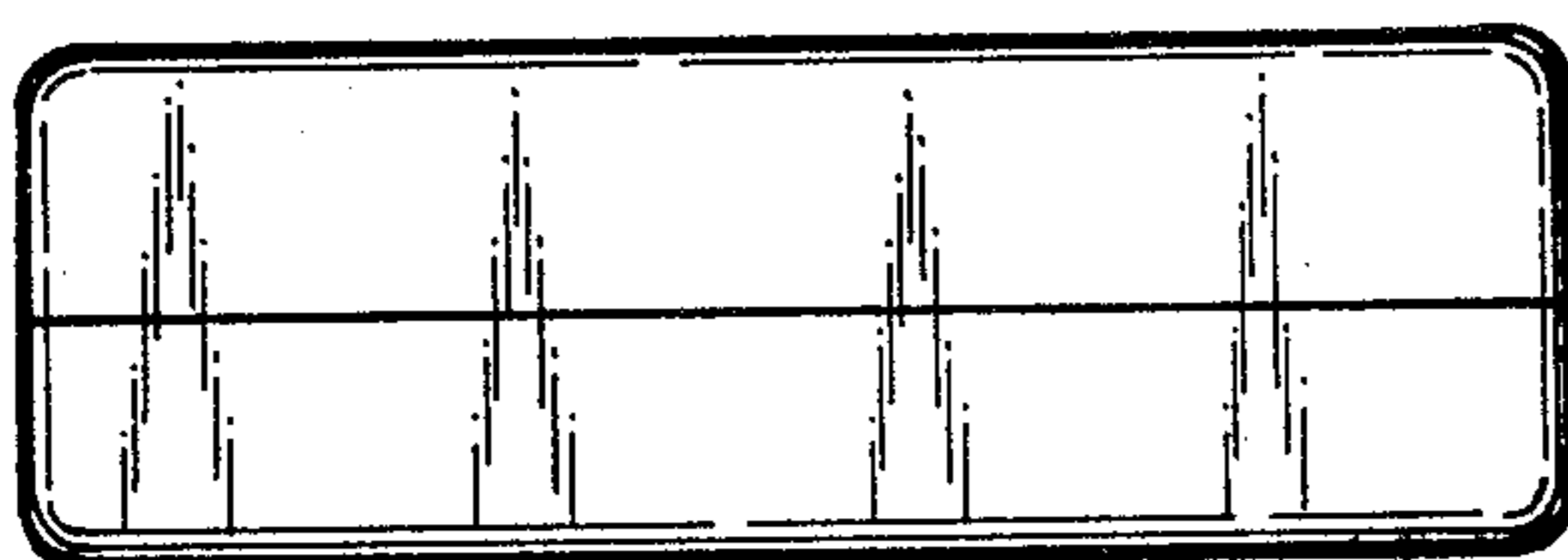


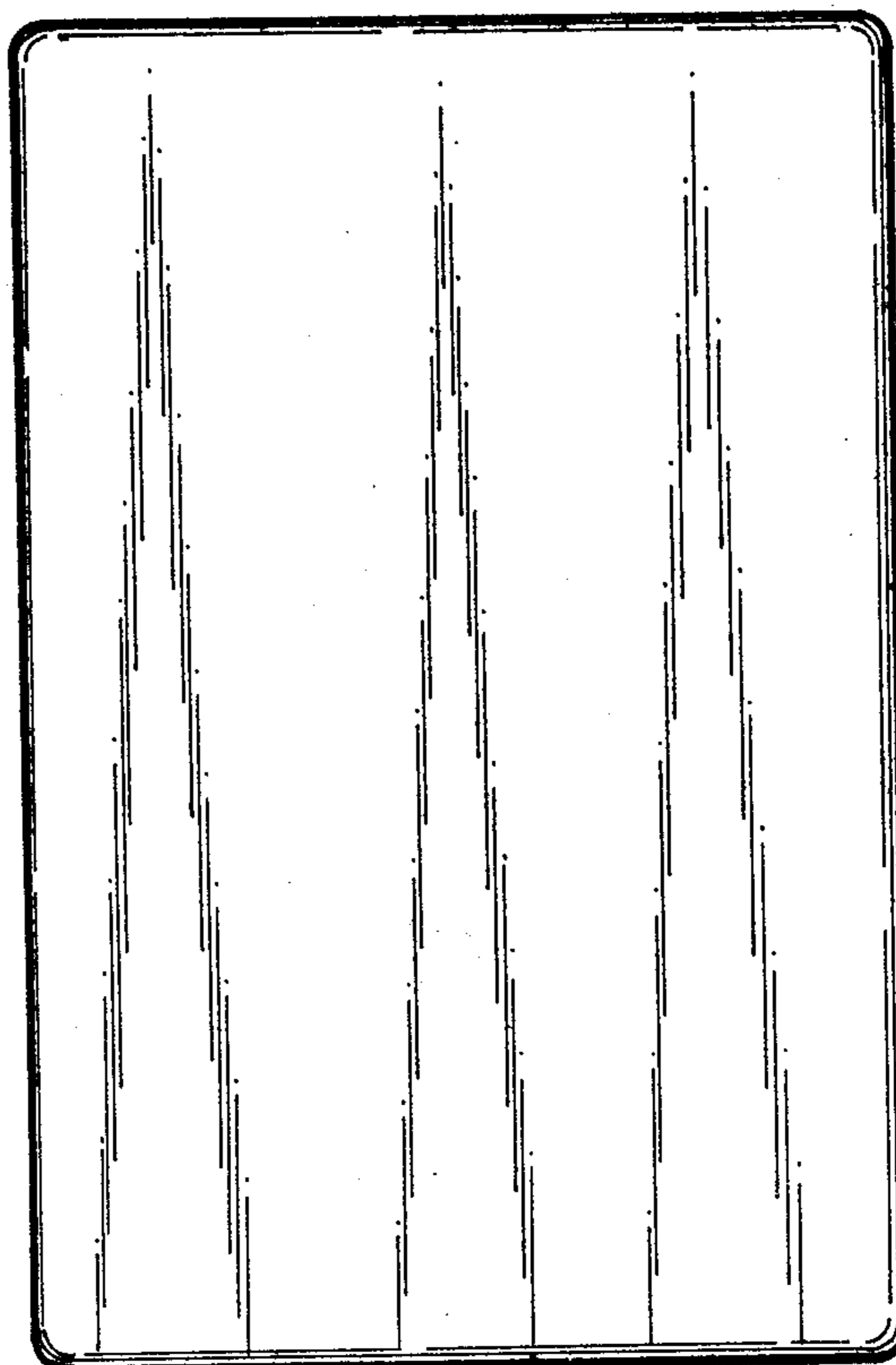
Fig. 2



*Fig. 3*



*Fig. 4*



*Fig. 5*